

Notice of References Cited	Application/Control No. 10/826,540	Applicant(s)/Patent Under Reexamination SCHREYER ET AL.	
	Examiner Chuck Huynh	Art Unit 2617	Page 1 of 1

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*	B	US-6,910,024	06-2005	Krishnamurthy et al.	705/400
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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